

Search Notes

Application/Control No.

10/518,756

Examiner

PAUL T. CHIN

Applicant(s)/Patent under
Reexamination

YOKOYAMA ET AL.

Art Unit

3652

SEARCHED

Class	Subclass	Date	Examiner
294	99.1		
	106	7/23/2007	PTC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR